

# SN74BCT29843 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS

SCBS022C – FEBRUARY 1989 – REVISED NOVEMBER 1993

- BiCMOS Process With CMOS Inputs and TTL Outputs Substantially Reduces Standby Current
- Input Has 50 kΩ
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic 300-mil DIPs (NT)

## description

The SN74BCT29843 features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers with parity, and working registers.

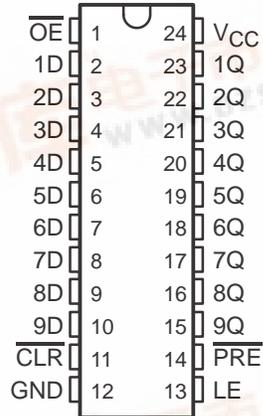
The nine latches are transparent D-type latches. When the latch-enable (LE) input is high, the Q outputs are complementary to the noninverting data (D) inputs.

A buffered output-enable ( $\overline{OE}$ ) input can be used to place the nine outputs in either a normal logic state (high or low level) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pull-up components.

The output enable ( $\overline{OE}$ ) does not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN74BCT29843 is characterized for operation from 0°C to 70°C.

DW OR NT PACKAGE  
(TOP VIEW)



FUNCTION TABLE

INPUTS					OUTPUT
$\overline{PRE}$	$\overline{CLR}$	$\overline{OE}$	LE	D	Q
L	X	L	X	X	H
H	L	L	X	X	L
H	H	L	H	L	L
H	H	L	H	H	H
H	H	L	L	X	Q <sub>0</sub>
X	X	H	X	X	Z

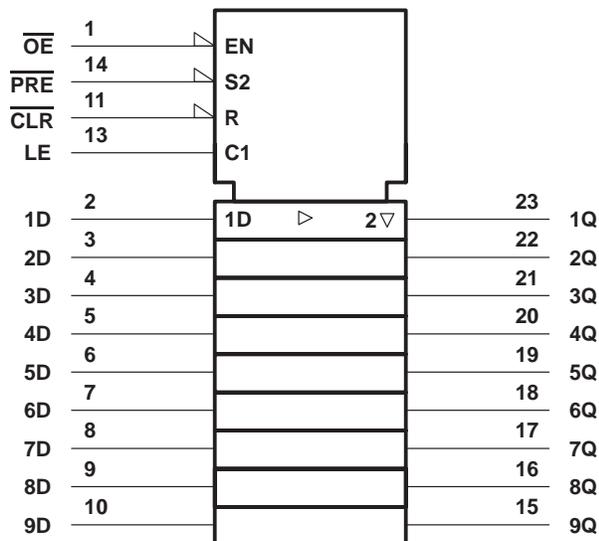


# SN74BCT29843

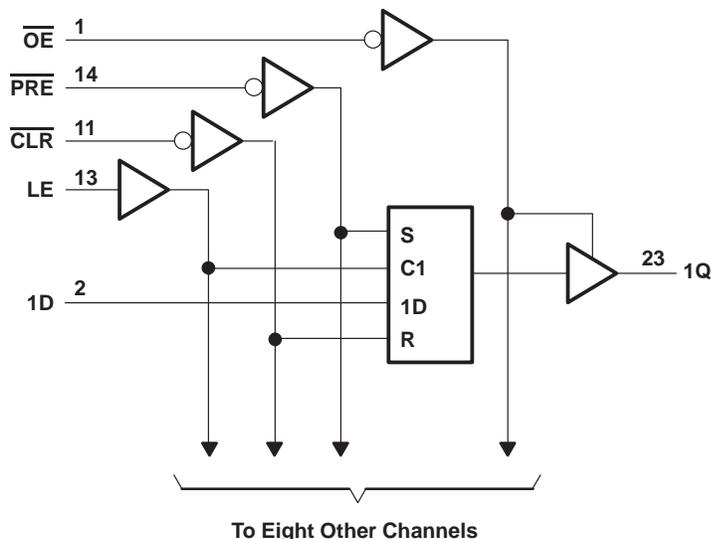
## 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS

SCBS022C – FEBRUARY 1989 – REVISED NOVEMBER 1993

### logic symbol†



### logic diagram (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, $V_{CC}$ .....	-0.5 V to 7 V
Input voltage range, $V_I$ (see Note 1) .....	-0.5 V to 7 V
Voltage range applied to any output in the disabled or power-off state, $V_O$ .....	-0.5 V to 7 V
Voltage range applied to any output in the high state, $V_{OH}$ .....	-0.5 V to $V_{CC}$
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-30 mA
Current into any output in the low state, $I_{OL}$ .....	96 mA
Operating free-air temperature range .....	0°C to 70°C
Storage temperature range .....	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond those indicated in the "recommended operating conditions" section of this specification is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

### recommended operating conditions

		MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			V
$V_{IL}$	Low-level input voltage			0.8	V
$I_{IK}$	Input clamp current			-18	mA
$I_{OH}$	High-level output current			-24	mA
$I_{OL}$	Low-level output current			48	mA
$T_A$	Operating free-air temperature	0		70	°C

**SN74BCT29843**  
**9-BIT BUS-INTERFACE D-TYPE LATCH**  
**WITH 3-STATE OUTPUTS**

SCBS022C – FEBRUARY 1989 – REVISED NOVEMBER 1993

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS		MIN	TYP†	MAX	UNIT
$V_{IK}$	$V_{CC} = 4.5\text{ V}$ ,	$I_I = -18\text{ mA}$			-1.2	V
$V_{OH}$	$V_{CC} = 4.5\text{ V}$	$I_{OH} = -15\text{ mA}$	2.4	3.2		V
		$I_{OH} = -24\text{ mA}$	2			
$V_{OL}$	$V_{CC} = 4.5\text{ V}$ ,	$I_{OL} = 48\text{ mA}$		0.35	0.55	V
$I_I$	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 7\text{ V}$			0.1	mA
$I_{IH}$	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 2.7\text{ V}$	-10		-75	$\mu\text{A}$
$I_{IL}$	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 0.4\text{ V}$			-0.2	mA
$I_{OS}^\ddagger$	$V_{CC} = 5.5\text{ V}$ ,	$V_O = 0$	-75		-275	mA
$I_{CCL}$	$V_{CC} = 5.5\text{ V}$ ,	Outputs open		24	35	mA
$I_{CCH}$	$V_{CC} = 5.5\text{ V}$ ,	Outputs open		3	7	mA
$I_{CCZ}$	$V_{CC} = 5.5\text{ V}$ ,	Outputs open		3	7	mA

† All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

‡ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

**timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)**

		MIN	MAX	UNIT
$t_w$	Pulse duration	$\overline{\text{PRE}}$ low	7	ns
		$\overline{\text{CLR}}$ low	5	
		LE high	4	
$t_{su}$	Setup time, data before LE $\downarrow$	High or low	1.5	ns
		$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ inactive	2	
$t_h$	Hold time, data after LE $\downarrow$	High or low	3.5	ns

**switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50\text{ pF}$  (unless otherwise noted) (see Note 2)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5\text{ V}$ , $T_A = 25^\circ\text{C}$			MIN	MAX	UNIT
			MIN	TYP	MAX			
$t_{PLH}$	$\overline{D}$	Q	1.5	4.5	7	1.5	8	ns
$t_{PHL}$			1.5	5.7	8	1.5	9	
$t_{PLH}$	LE	Q	1.5	6	8	1.5	10	ns
$t_{PHL}$			1.5	6	8	1.5	10	
$t_{PLH}$	$\overline{\text{PRE}}$	Q	1.5	6	8	1.5	12	ns
$t_{PHL}$			1.5	6	10	1.5	12	
$t_{PLH}$	$\overline{\text{CLR}}$	Q	1.5	6	10	1.5	12	ns
$t_{PHL}$			1.5	6	10	1.5	12	
$t_{PZH}$	$\overline{\text{OE}}$	Q	2	10	13	2	15	ns
$t_{PZL}$			2	10	13	2	15	
$t_{PHZ}$	$\overline{\text{OE}}$	Q	2	5	7	2	8	ns
$t_{PLZ}$			2	5	7	2	8	

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



## **IMPORTANT NOTICE**

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.